 Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/769,530	MIYOSHI ET AL.	
Examiner	Art Unit	_
Yixing Qin	2625	

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Class	Subclass	Date	Examiner
			
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
358	1.15	10/10/2006	YQ
	search on 0/06	10/10/2006	YQ

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DATE	EXMR
10/10/2006	YQ
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